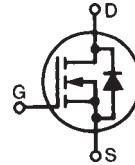


# PolarHT™ Power MOSFET

**IXTQ 110N10P**  
**IXTT 110N10P**

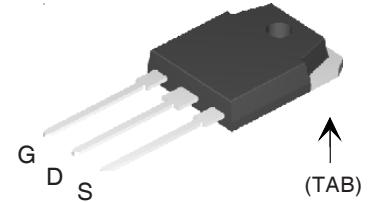
**V<sub>DSS</sub> = 100 V**  
**I<sub>D25</sub> = 110 A**  
**R<sub>DS(on)</sub> = 15 mΩ**

## N-Channel Enhancement Mode

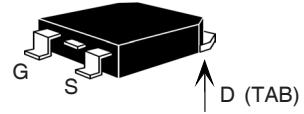


Symbol	Test Conditions	Maximum Ratings		
V <sub>DSS</sub>	T <sub>J</sub> = 25°C to 175°C	100	V	
V <sub>DGR</sub>	T <sub>J</sub> = 25°C to 175°C; R <sub>GS</sub> = 1 MΩ	100	V	
V <sub>GSM</sub>		±20	V	
I <sub>D25</sub>	T <sub>c</sub> = 25°C	110	A	
I <sub>D(RMS)</sub>	External lead current limit	75	A	
I <sub>DM</sub>	T <sub>c</sub> = 25°C, pulse width limited by T <sub>JM</sub>	250	A	
I <sub>AR</sub>	T <sub>c</sub> = 25°C	60	A	
E <sub>AR</sub>	T <sub>c</sub> = 25°C	40	mJ	
E <sub>AS</sub>	T <sub>c</sub> = 25°C	1.0	J	
dv/dt	I <sub>S</sub> ≤ I <sub>DM</sub> , di/dt ≤ 100 A/μs, V <sub>DD</sub> ≤ V <sub>DSS</sub> , T <sub>J</sub> ≤ 150°C, R <sub>G</sub> = 4 Ω	10	V/ns	
P <sub>D</sub>	T <sub>c</sub> = 25°C	480	W	
T <sub>J</sub>		-55 ... +175	°C	
T <sub>JM</sub>		175	°C	
T <sub>stg</sub>		-55 ... +150	°C	
T <sub>L</sub>	1.6 mm (0.062 in.) from case for 10 s	300	°C	
M <sub>d</sub>	Mounting torque (TO-3P)	1.13/10	Nm/lb.in.	
Weight	TO-3P TO-268	5.5 5.0	g g	

TO-3P (IXTQ)



TO-268 (IXTT)



G = Gate  
S = Source

D = Drain  
TAB = Drain

## Features

- International standard packages
- Unclamped Inductive Switching (UIS) rated
- Low package inductance
  - easy to drive and to protect

## Advantages

- Easy to mount
- Space savings
- High power density

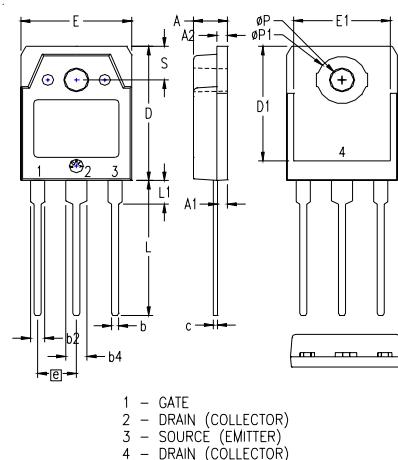
**PolarHT™ DMOS transistors utilize proprietary designs and process. US patent is pending.**

Symbol	Test Conditions (T <sub>J</sub> = 25°C, unless otherwise specified)	Characteristic Values		
		Min.	Typ.	Max.
V <sub>DSS</sub>	V <sub>GS</sub> = 0 V, I <sub>D</sub> = 250 μA	100		V
V <sub>GS(th)</sub>	V <sub>DS</sub> = V <sub>GS</sub> , I <sub>D</sub> = 250 μA	2.5		5.0 V
I <sub>GSS</sub>	V <sub>GS</sub> = ±20 V <sub>DC</sub> , V <sub>DS</sub> = 0		±100	nA
I <sub>DSS</sub>	V <sub>DS</sub> = V <sub>DSS</sub> V <sub>GS</sub> = 0 V	T <sub>J</sub> = 150°C	25 250	μA
R <sub>DS(on)</sub>	V <sub>GS</sub> = 10 V, I <sub>D</sub> = 0.5 I <sub>D25</sub> Pulse test, t ≤ 300 μs, duty cycle d ≤ 2 %		15	mΩ

Symbol	Test Conditions	Characteristic Values		
		Min.	Typ.	Max.
$g_{fs}$	$V_{DS} = 10 \text{ V}$ ; $I_D = 0.5 I_{D25}$ , pulse test	30	40	S
$C_{iss}$ $C_{oss}$ $C_{rss}$	$V_{GS} = 0 \text{ V}$ , $V_{DS} = 25 \text{ V}$ , $f = 1 \text{ MHz}$	3550	pF	
		1370	pF	
		440	pF	
$t_{d(on)}$ $t_r$ $t_{d(off)}$ $t_f$	$V_{GS} = 10 \text{ V}$ , $V_{DS} = 0.5 V_{DSS}$ , $I_D = 60 \text{ A}$ $R_G = 4 \Omega$ (External)	21	ns	
		25	ns	
		65	ns	
		25	ns	
$Q_{g(on)}$ $Q_{gs}$ $Q_{gd}$	$V_{GS} = 10 \text{ V}$ , $V_{DS} = 0.5 V_{DSS}$ , $I_D = 0.5 I_{D25}$	110	nC	
		25	nC	
		62	nC	
$R_{thJC}$			0.31 K/W	
$R_{thCK}$	(TO-3P)	0.21	K/W	

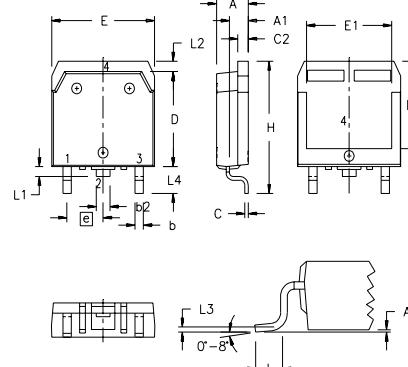
**Source-Drain Diode**
**Characteristic Values**
 $(T_J = 25^\circ\text{C}, \text{unless otherwise specified})$ 

Symbol	Test Conditions	Min.	typ.	Max.
$I_s$	$V_{GS} = 0 \text{ V}$		110	A
$I_{SM}$	Repetitive		250	A
$V_{SD}$	$I_F = I_S$ , $V_{GS} = 0 \text{ V}$ , Pulse test, $t \leq 300 \mu\text{s}$ , duty cycle $d \leq 2 \%$		1.5	V
$t_{rr}$ $Q_{RM}$	$I_F = 25 \text{ A}$ $-di/dt = 100 \text{ A}/\mu\text{s}$ $V_R = 50 \text{ V}$	130	ns	
		2.0	$\mu\text{C}$	

**TO-3P (IXTQ) Outline**


SYM	INCHES		MILLIMETERS	
	MIN	MAX	MIN	MAX
A	.185	.193	4.70	4.90
A1	.051	.059	1.30	1.50
A2	.057	.065	1.45	1.65
b	.035	.045	0.90	1.15
b2	.075	.087	1.90	2.20
b4	.114	.126	2.90	3.20
c	.022	.031	0.55	0.80
D	.780	.791	19.80	20.10
D1	.665	.677	16.90	17.20
E	.610	.622	15.50	15.80
E1	.531	.539	13.50	13.70
e	.215 BSC		5.45 BSC	
L	.779	.795	19.80	20.20
L1	.134	.142	3.40	3.60
$\varnothing P$	.126	.134	3.20	3.40
$\varnothing P1$	.272	.280	6.90	7.10
S	.193	.201	4.90	5.10

All metal areas are tin plated.

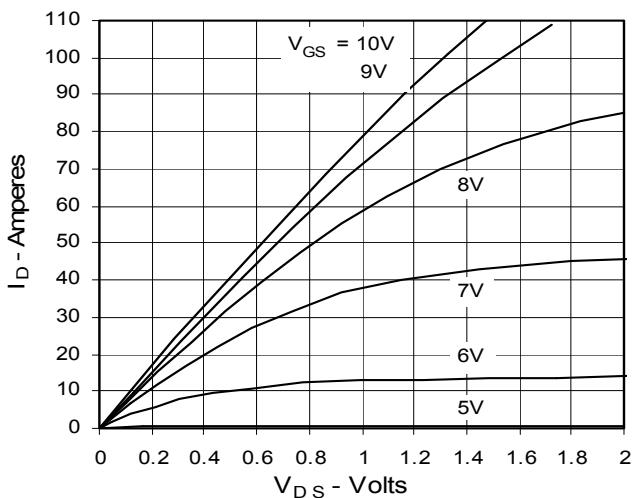
**TO-268 Outline**


SYM	INCHES		MILLIMETERS	
	MIN	MAX	MIN	MAX
A	.193	.201	4.90	5.10
A1	.106	.114	2.70	2.90
A2	.001	.010	0.02	0.25
b	.045	.057	1.15	1.45
b2	.075	.083	1.90	2.10
C	.016	.026	0.40	0.65
C2	.057	.063	1.45	1.60
D	.543	.551	13.80	14.00
D1	.488	.500	12.40	12.70
E	.624	.632	15.85	16.05
E1	.524	.535	13.30	13.60
e	.215 BSC		5.45 BSC	
H	.736	.752	18.70	19.10
L	.094	.106	2.40	2.70
L1	.047	.055	1.20	1.40
L2	.039	.045	1.00	1.15
L3	.010 BSC		0.25 BSC	
L4	.150	.161	3.80	4.10

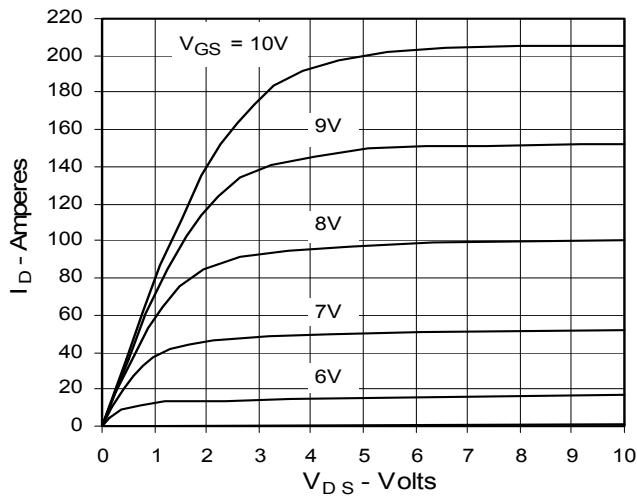
IXYS reserves the right to change limits, test conditions, and dimensions.

IXYS MOSFETs and IGBTs are covered by 4,835,592 4,881,106 5,017,508 5,049,961 5,187,117 5,381,025 6,162,665 6,306,728 B1 6,534,343 6,683,344 one or more of the following U.S. patents: 4,850,072 4,931,844 5,034,796 5,063,307 5,237,481 5,486,715 6,259,123 B1 6,404,065 B1 6,583,505 6,710,405 B2

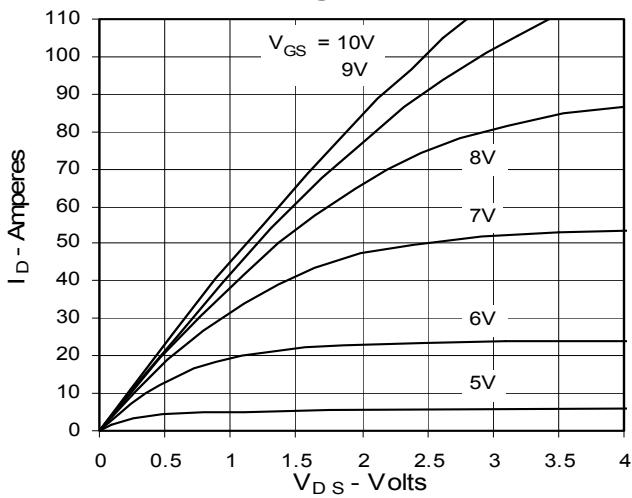
**Fig. 1. Output Characteristics  
@ 25°C**



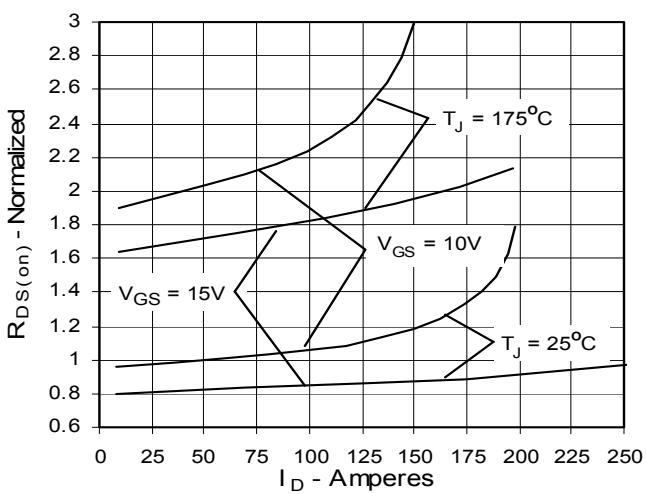
**Fig. 2. Extended Output Characteristics  
@ 25°C**



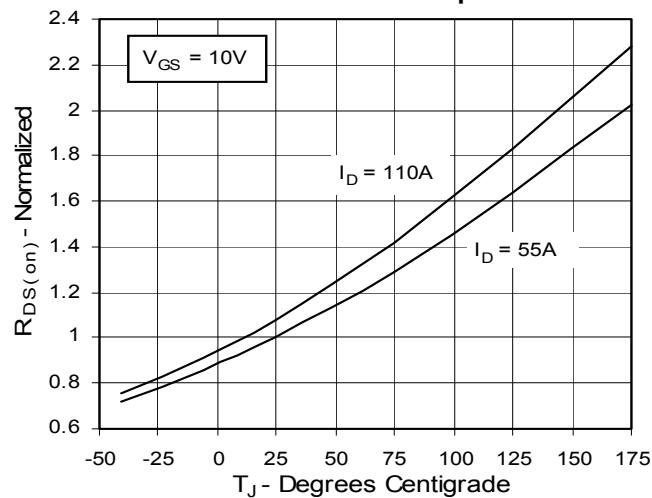
**Fig. 3. Output Characteristics  
@ 150°C**



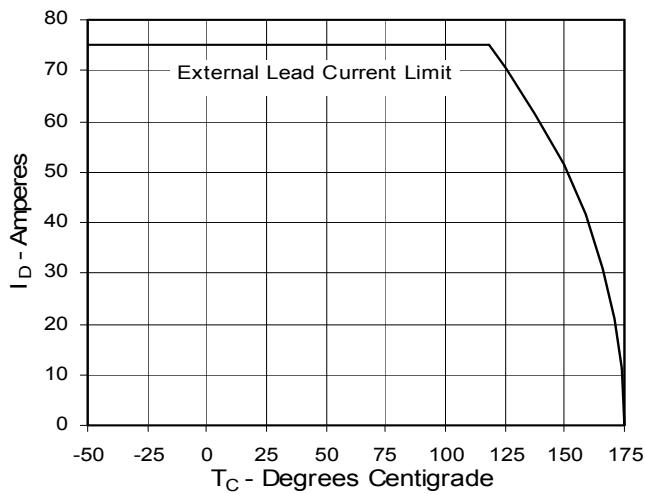
**Fig. 5.  $R_{DS(on)}$  Normalized to 0.5  $I_{D25}$  Value vs. Drain Current**

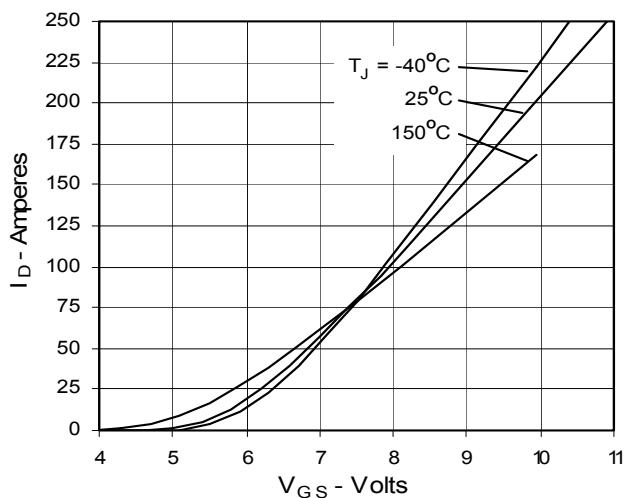
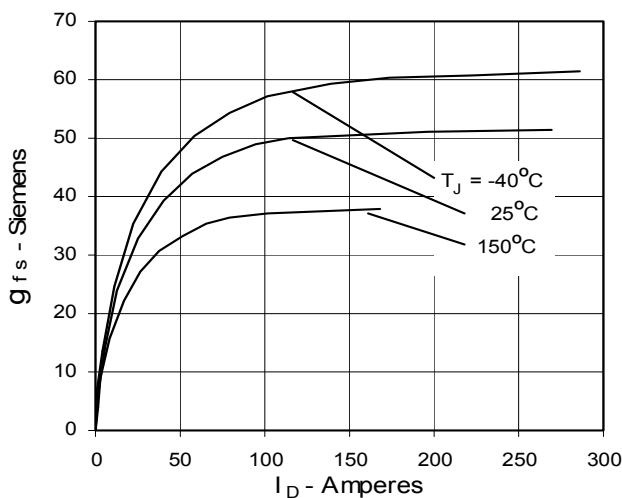
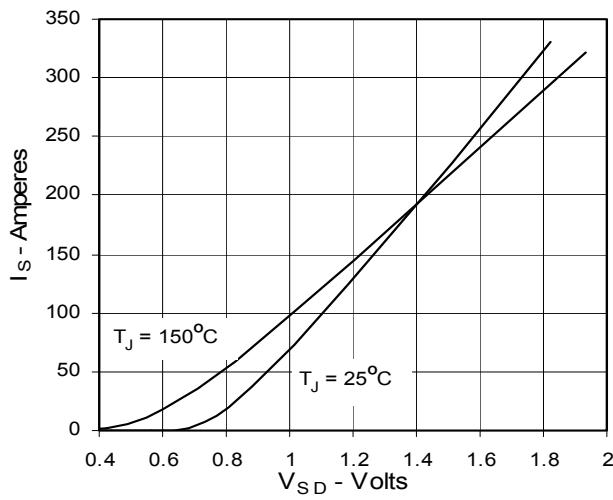
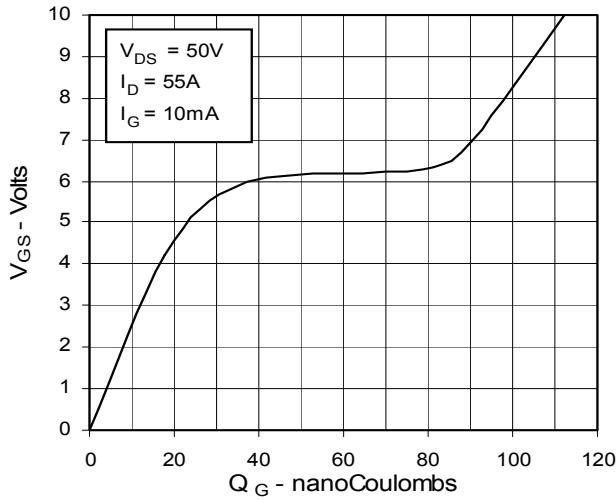
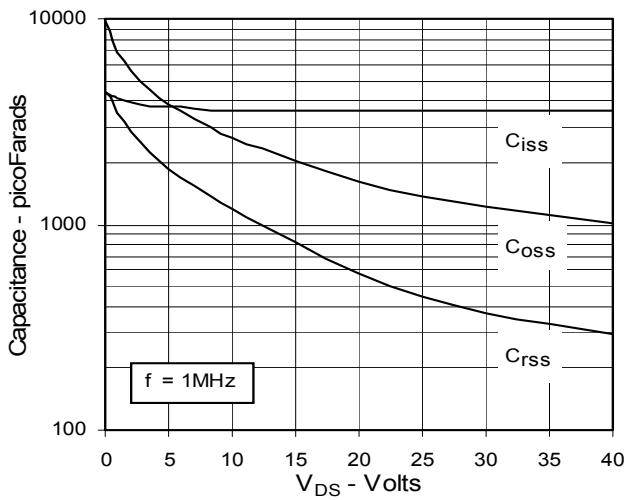
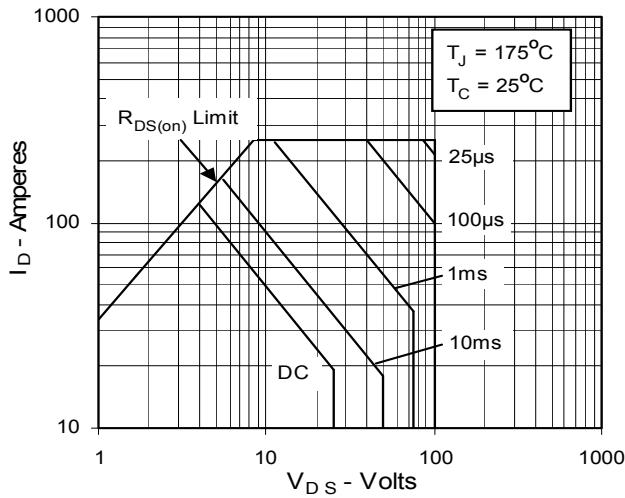


**Fig. 4.  $R_{DS(on)}$  Normalized to 0.5  $I_{D25}$  Value vs. Junction Temperature**



**Fig. 6. Drain Current vs. Case Temperature**



**Fig. 7. Input Admittance**

**Fig. 8. Transconductance**

**Fig. 9. Source Current vs. Source-To-Drain Voltage**

**Fig. 10. Gate Charge**

**Fig. 11. Capacitance**

**Fig. 12. Forward-Bias Safe Operating Area**


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**Fig. 13. Maximum Transient Thermal Resistance**